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AMENDMENT TO THE CLAIMS

This listing of claims will replace all prior versions and listings of claims in this application:

Listing of Claims:

- 1. (Original) A non-volatile multi-stable memory device, comprising:
- a first electrode;
- a second electrode; and
- a composite medium disposed between and in contact with the first and second electrodes;

wherein the composite medium comprises a layer of discrete charge trapping particles so that an electrical resistance measured across the first and second electrodes is selectively variable between a lower resistance R_{on} and a higher resistance R_{off} ;

wherein R_{on} is selected by applying a turn-on potential V_{on} between the first and second electrodes;

wherein R_{off} is selected by applying a turn-off potential V_{off} between the first and second electrodes;

wherein the absolute value of the turn-off potential, $\|V_{off}\|$, is greater than the absolute value of the turn-on potential, $\|V_{on}\|$; and

wherein the turn-off potential, V_{off} and the turn-on potential, V_{on} have the same polarity.

2. (Original) The memory device of claim 1, wherein the composite medium further comprises a layer of charge transporting semiconductor material in which the layer of discrete charge trapping particles is embedded, has a "primary band gap" between approximately 1.5 and 6 eV.

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- 3. (Original) The memory device of claim 1, wherein the absolute value of the turn-on potential, $\|V_{on}\|$ is greater than the absolute value of a predetermined threshold potential, $\|V_{T}\|$ of the composite medium.
- 4. (Original) The memory device of claim 1, wherein the charge trapping particles comprise discrete atoms embedded in the layer of charge transporting material.
- 5. (Original) The memory device of claim 1, wherein the charge trapping particles comprise discrete ions embedded in the layer of charge transporting material.
- 6. (Original) The memory device of claim 1, wherein the charge trapping particles comprise discrete molecules embedded in the layer of charge transporting material.
- 7. (Original) The memory device of claim 1, wherein the charge trapping particles comprise discrete molecular clusters embedded in the layer of charge transporting material.
- 9. (Original) The memory device of claim 1, wherein the charge trapping particles are metallic.
- 10. (Original) The memory device of claim 2, wherein the charge trapping particles are semiconducting with a band gap less than the band gap of the charge transporting semiconductor material.

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- 11. (Original) The memory device of claim 1, wherein the charge trapping particles comprise discrete nanoparticles embedded in the layer of charge transporting material.
- 12. (Original) The memory device of claim 1, wherein the layer of discrete charge trapping particles is separated from the electrodes by intermediate layers of charge transporting material.
- 13. (Original) The memory device of claim 1, wherein upon applying the turn-on potential $V_{\rm on}$ between the first electrode and the second electrode, substantially no charge is retained by the composite medium, and wherein a corresponding on state is maintained for at least 10 seconds.
- 14. (Original) The memory device of claim 1, wherein upon applying the turn-off potential $V_{\rm off}$ between the first electrode and the second electrode, the composite medium retains a charge with a charge dissipation decay time of at least 10 seconds.
- 15. (Original) The memory device of claim 1, wherein $|R_{on}|$ and $|R_{off}|$ differ by at least a factor of approximately 2.
- 16. (Original) The memory device of claim 2, wherein the charge transporting semiconductor material comprises an organic electron transport material.
- 17. (Original) The memory device of claim 16, wherein the organic electron transport material comprises aluminum triquinolate.

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- 18. (Original) The memory device of claim 2, wherein the charge transporting semiconductor material comprises an organic hole transport material.
- 19. (Original) The memory device of claim 18, wherein the organic hole transport material is NPB.
- 20. (Original) The memory device of claim 2, wherein the charge transporting semiconductor material comprises a crosslinkable arylamine polymer.
- 21. (Original) The memory device of claim 20, wherein the arylamine polymer is HTPA.
- 22. (Original) The memory device of claim 2, wherein the charge transporting semiconductor material comprises is inorganic with a band gap greater than approximately 2 eV.
- 23. (Original) The memory device of claim 22, wherein the semiconductor is SiO.
- 24. (Original) The memory device of claim 2, where the charge trapping particles form a separate layer within the charge transporting semiconductor material.
- 25. (Original) The memory device of claim 2, where the charge trapping particles are dispersed in the charge transporting semiconductor material.

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26. (Original) The memory device of claim 2, where the charge transporting semiconductor material comprises a plurality of layers; and wherein at least one of the plurality of layers comprises a dispersion of charge storage particles.

- 27. (Original) A bistable switching element, comprising:
- a first electrode:
- a second electrode; and
- a composite medium disposed between and in contact with the first and second electrodes;

wherein the composite medium comprises a layer of discrete charge trapping particles so that an electrical resistance measured across the first and second electrodes is selectively variable between a lower resistance R_{on} and a higher resistance R_{off} :

wherein R_{on} is selected by applying a turn-on potential V_{on} between the first and second electrodes;

wherein R_{off} is selected by applying a turn-off potential V_{off} between the first and second electrodes;

wherein the absolute value of the turn-off potential, $\|V_{off}\|$, is greater than the absolute value of the turn-on potential, $\|V_{on}\|$; and

wherein the turn-off potential, V_{off} and the turn-on potential, V_{on} have the same polarity.

28. (Original) The bistable switching element of claim 27, wherein the composite medium further comprises a layer of charge transporting semiconductor material in which the layer of discrete charge trapping particles is embedded, has a "primary band gap" between approximately 1.5 and 6 eV.

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29. (Original) The bistable switching element of claim 28, wherein the layer of charge transporting semiconductor material has a band gap that is greater that approximately 2 eV.

30. (Original) The bistable switching element of claim 27, wherein the charge trapping particles and the first electrode are selected so that charges of a predetermined polarity is allowed to be injected into the composite medium; and

wherein the charge trapping particles and the second electrode are selected so that charges of a opposite polarity are prevented from being injected into the composite medium.

- 31. (Original) The bistable switching element of claim 27, wherein the discrete trapping particles are distributed throughout the semiconductor material so that a maximum density of the discrete trapping particles is located nearly equidistantly between the first and second electrodes.
- 32. (Original) A memory system comprised of an array of non-volatile multi-stable memory devices, each memory device comprising:
 - a first electrode:
 - a second electrode; and
- a composite medium disposed between and in contact with the first and second electrodes;

wherein the composite medium comprises a layer of discrete charge trapping particles so that an electrical resistance measured across the first and second electrodes is selectively variable between a lower resistance R_{on} and a higher resistance R_{off} ;

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wherein R_{on} is selected by applying a turn-on potential V_{on} between the first and second electrodes;

wherein R_{off} is selected by applying a turn-off potential V_{off} between the first and second electrodes;

wherein the absolute value of the turn-off potential, $\|V_{off}\|$, is greater than the absolute value of the turn-on potential, $\|V_{on}\|$; and

wherein the turn-off potential, V_{off} and the turn-on potential, V_{on} have the same polarity.

- 33. (Original) A switching system comprised of an array of multi-stable switching elements, each element comprising:
 - a first electrode;
 - a second electrode; and
- a composite medium disposed between and in contact with the first and second electrodes;

wherein the composite medium comprises a layer of discrete charge trapping particles so that an electrical resistance measured across the first and second electrodes is selectively variable between a lower resistance R_{on} and a higher resistance R_{off} ;

wherein R_{on} is selected by applying a turn-on potential V_{on} between the first and second electrodes:

wherein R_{off} is selected by applying a turn-off potential V_{off} between the first and second electrodes;

wherein the absolute value of the turn-off potential, $\|V_{off}\|$, is greater than the absolute value of the turn-on potential, $\|V_{on}\|$; and

wherein the turn-off potential, V_{off} and the turn-on potential, V_{on} have the same polarity.

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- 34. (Original) The switching system of claim 33, wherein the composite medium further comprises a layer of charge transporting semiconductor material in which the layer of discrete charge trapping particles is embedded, has a "primary band gap" between approximately 1.5 and 6 eV.
- 35. (Original) The switching system of claim 34, wherein the layer of charge transporting semiconductor material has a band gap that is greater that approximately 2 eV.
- 36. (Original) The switching system of claim 33, wherein the charge trapping particles and the first electrode are selected so that charges of a predetermined polarity is allowed to be injected into the composite medium; and

wherein the charge trapping particles and the second electrode are selected so that charges of a opposite polarity are prevented from being injected into the composite medium.

- 37. (Original) The switching system of claim 33, wherein the discrete trapping particles are distributed throughout the semiconductor material so that a maximum density of the discrete trapping particles is located nearly equidistantly between the first and second electrodes.
- 38. (Withdrawn) A method of forming a non-volatile multi-stable memory device, comprising:

depositing a first electrically conductive layer onto a substrate to form a first electrode;

depositing a composite medium onto the first electrode; and

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depositing a second electrically conductive layer onto the composite medium to form a second electrode;

wherein the composite medium comprises a layer of discrete charge trapping particles so that an electrical resistance measured across the first and second electrodes is selectively variable between a lower resistance R_{on} and a higher resistance R_{off} ;

wherein R_{on} is selected by applying a turn-on potential V_{on} between the first and second electrodes;

wherein R_{off} is selected by applying a turn-off potential V_{off} between the first and second electrodes:

wherein the absolute value of the turn-off potential, $\|V_{off}\|$, is greater than the absolute value of the turn-on potential, $\|V_{on}\|$; and

wherein the turn-off potential, V_{off} and the turn-on potential, V_{on} have the same polarity.

39. (Original) A method of using a non-volatile multi-stable memory device that includes a first electrode, a second electrode, and a composite medium disposed between and in contact with the first and second electrodes, wherein the composite medium comprises a layer of discrete charge trapping particles so that an electrical resistance measured across the first and second electrodes is selectively variable between a lower resistance Ron and a higher resistance Roff; the method comprising:

selecting the lower resistance R_{on} by applying a turn-on potential V_{on} between the first and second electrodes;

selecting the higher resistance $R_{\rm off}$ by applying a turn-off potential $V_{\rm off}$ between the first and second electrodes;

wherein the absolute value of the turn-off potential, $\|V_{off}\|$, is greater than the absolute value of the turn-on potential, $\|V_{off}\|$; and

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wherein the turn-off potential, V_{off} and the turn-on potential, V_{on} have the same polarity.

- 40. (Original) The method of claim 39, further comprising reading a state of the multi-stable memory device by applying a reading voltage pulse.
 - 41. (Original) A logical device comprising:
 - a first electrode:
 - a second electrode; and
- a composite medium disposed between and in contact with the first and second electrodes;

wherein the composite medium comprises a layer of discrete charge trapping particles so that an electrical resistance measured across the first and second electrodes is selectively variable between a lower resistance R_{off} ;

wherein R_{on} is selected by applying a turn-on potential V_{on} between the first and second electrodes;

wherein R_{off} is selected by applying a turn-off potential V_{off} between the first and second electrodes;

wherein the absolute value of the turn-off potential, $\|V_{eff}\|$, is greater than the absolute value of the turn-on potential, $\|V_{en}\|$; and

wherein the turn-off potential, V_{off} and the turn-on potential, V_{on} have the same polarity.